

Notice of References Cited	Application/Control No. 10/811,087	Applicant(s)/Patent Under Reexamination PAN ET AL.	
	Examiner M. N. Von Buhr	Art Unit 2125	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0208389 A1	11-2003	Kurihara et al.	705/7
*	B	US-2003/0126103 A1	07-2003	Chen et al.	706/50
*	C	US-2002/0169657 A1	11-2002	Singh et al.	705/10
*	D	US-2002/0107720 A1	08-2002	Martin, Ernest	705/10
*	E	US-7,050,879 B1	05-2006	Wang et al.	700/121
*	F	US-7,039,595 B1	05-2006	Lilly et al.	705/8
*	G	US-6,725,122 B2	04-2004	Mori et al.	700/121
*	H	US-6,415,260 B1	07-2002	Yang et al.	705/10
*	I	US-6,311,094 B1	10-2001	Iriuchijima et al.	700/100
*	J	US-6,272,389 B1	08-2001	Dietrich, Brenda Lynn	700/101
*	K	US-6,226,561 B1	05-2001	Tamaki et al.	700/100
*	L	US-6,078,893 A	06-2000	Ouimet et al.	705/10
*	M	US-5,884,300 A	03-1999	Brockman, Richard	707/2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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